

# NTE74LS166 Integrated Circuit TTL – 8-Bit Parallel or Serial-In/Serial-Out Shift Register

### **Description:**

The NTE74LS166 is an 8-bit parallel-in or serial-in, serial-out shift register in a 16-Lead plastic DIP type package having the complexity of 77 equivalent gates on a monolithic chip. The parallel-in or serial-in modes are established by the shift/load input. When high, this input enables the serial data input and couples the eight flip-flops for serial shifting with each clock pulse. When low, the parallel (broadside) data inputs are enabled and synchronous loading occurs on the next clock pulse. During parallel loading, serial data flow is inhibited. Clocking is accomplished on the low-to-high-level edge of the clock pulse through a two-input positive NOR gate permitting one input to be used as a clock enable or clock-inhibit function. Holding either of the clock inputs high inhibits clocking; holding either low enables the other clock input. This, of course, allows the system clock to be free-running and the register can be stopped on command with the other clock input. The clock inhibit input should be changed to the high level only while the clock input is high. A buffered, direct clear input overrides all other inputs, including the clock, and sets all flip-flops to zero.

The NTE74LS166 is compatible with most other TTL logic families and all inputs are buffered to lower the drive requirements to one LS-TTL standard load. Input clamping diodes minimize switching transients an simplify system design.

#### Features:

- Synchronous Load
- Direct Overriding Clear
- Parallel-to-Serial Conversion

### Absolute Maximum Ratings: (Note 1)

Supply Voltage, V <sub>CC</sub>	7V
DC Input Voltage, V <sub>IN</sub>	7V
Power Dissipation, P <sub>D</sub>	100mW
Operating Temperature Range, T <sub>A</sub>	0°C to +70°C
Storage Temperature Range, T <sub>stg</sub>	-65°C to +150°C

Note 1. Unless otherwise specified, all voltages are referenced to GND.

## **Recommended Operating Conditions:**

Parameter	Symbol	Min	Тур	Max	Unit
Supply Voltage	V <sub>CC</sub>	4.75	5.0	5.25	V
High-Level Input Voltage	V <sub>IH</sub>	2	_	_	V
Low-Level Input Voltage	V <sub>IL</sub>	_	_	0.8	V
High-Level Output Current	Іон	_	_	-0.4	mA
Low-Level Output Current	l <sub>OL</sub>	_	_	8	mA
Clock Frequency	f <sub>clock</sub>	0	_	25	MHz
Width of Clear Pulse	t <sub>w</sub>	20	_	_	ns
Width of Clock Pulse	t <sub>w</sub>	25	_	_	ns
Mode-Control Setup Time	t <sub>su</sub>	30	_	-	ns
Data Setup Time	t <sub>su</sub>	20	_	-	ns
Hold Time at Any Input	t <sub>h</sub>	0	_	_	ns
Operating Temperature Range	T <sub>A</sub>	0	_	+70	°C

### **Electrical Characteristics**: (Note 2, Note 3)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
Input Clamp Voltage	V <sub>IK</sub>	$V_{CC} = MIN, I_I = -18mA$			-	-1.5	V
High Level Output Voltage	V <sub>OH</sub>	$V_{CC} = MIN, V_{IH} = 2V, V_{IL} = MAX, I_{OH} = -0.4mA$			3.4	_	V
Low Level Output Voltage	V <sub>OL</sub>	$V_{CC} = MIN, V_{IH} = 2V, V_{IL} = MAX$	I <sub>OL</sub> = 4mA	_	0.25	0.4	V
			I <sub>OL</sub> = 8mA	_	0.35	0.5	V
Input Current	I <sub>I</sub>	V <sub>CC</sub> = MAX, V <sub>I</sub> = 7V		_	_	0.1	mA
High Level Input Current	I <sub>IH</sub>	$V_{CC} = MAX, V_I = 2.7V$		_	-	20	μΑ
Low Level Input Current	I <sub>IL</sub>	$V_{CC} = MAX, V_I = 0.4V$		_	-	-0.4	mA
Short-Circuit Output Current	los	V <sub>CC</sub> = MAX, Note 4			_	-100	mA
Supply Current	I <sub>CC</sub>	V <sub>CC</sub> = MAX, Note 5		_	20	32	mA

- Note 2. .For conditions shown as MIN or MAX, use the appropriate value specified under "Recommended Operation Conditions".
- Note 3. All typical values are at  $V_{CC} = 5V$ ,  $T_A = +25$ °C.
- Note 4. Not more than one output should be shorted at a time and duration of short–circuit should not exceed one second.
- Note 5. With the outputs open, 4.5V applied to th serial input and all other inputs except the clock grounded, I<sub>CC</sub> is measured after a momentary GND, then 4.5V, is applied to clock.

# <u>Switching Characteristics</u>: $(V_{CC} = 5V, T_A = +25^{\circ}C \text{ unless otherwise specified})$

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Maximum Clock Frequency	f <sub>max</sub>	$R_L = 2k\Omega$ , $C_L = 15pF$	25	35	_	MHz
Propagation Delay Time (From Clear Input to High-to-Low Level Output)	t <sub>PHL</sub>		_	19	30	ns
Propagation Delay Time (From Clock Input to High-to-Low Level Output)	t <sub>PHL</sub>		7	14	25	ns
Propagation Delay Time (From Clock Input to Low-to-High Level Output)	t <sub>PLH</sub>		5	11	20	ns

# **Function Table:**

Inputs				Internal				
	SHIFT/	Clock			Parallel	Outputs		Output
CLEAR	LOAD	Inhibit	Clock	Serial	A H	$Q_A$	$Q_B$	$Q_{H}$
L	X	Х	X	Х	Х	L	L	L
Н	Х	L	L	Х	Х	$Q_{A0}$	$Q_{B0}$	Q <sub>H0</sub>
Н	L	L	1	X	ah	а	b	h
Н	Н	L	1	Н	Х	Н	$Q_{An}$	$Q_Gn$
Н	Н	L	1	L	X	L	$Q_{An}$	$Q_Gn$
Н	X	Н	1	Х	Х	$Q_{A0}$	Q <sub>B0</sub>	Q <sub>H0</sub>

